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- 4-Ω Switch Connection Between Two Ports
- Isolation Under Power-Off Conditions
- Make-Before-Break Feature
- Internal 500- $\Omega$  Pulldown Resistors to Ground
- A-Port Inputs/Outputs Have Equivalent 25-Ω Series Resistors, So No External Resistors Are Required
- Package Options Include Plastic Thin Shrink Small-Outline (DGG), Thin Very Small-Outline (DGV), and 300-mil Shrink Small-Outline (DL) Packages

NOTE: For order entry:

The DGG package is abbreviated to G, and the DGV package is abbreviated to V.

#### description

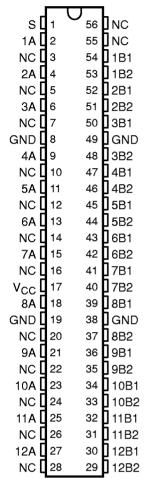
The SN74CBTLV162292 is a 12-bit 1-of-2 high-speed FET multiplexer/demultiplexer. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

When the select (S) input is low, port A is connected to port B1 and  $R_{INT}$  is connected to port B2. When S is high, port A is connected to port B2 and  $R_{INT}$  is connected to port B1.

The A-port inputs/outputs include equivalent  $25-\Omega$  series resistors to reduce overshoot and undershoot.

The SN74CBTLV162292 is characterized for operation from –40°C to 85°C.

## DGG, DGV, OR DL PACKAGE (TOP VIEW)



NC - No internal connection

#### **FUNCTION TABLE**

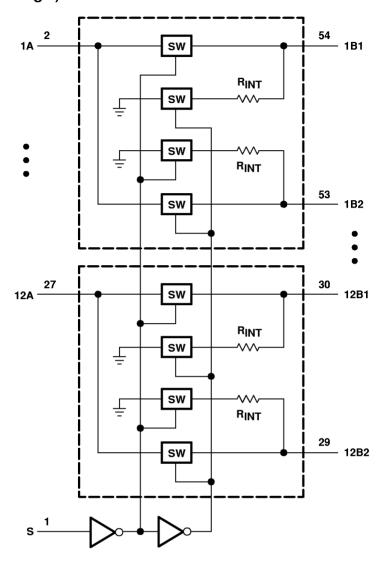
INPUT S	FUNCTION
L	A port = B1 port R <sub>INT</sub> = B2 port
Н	A port = B2 port R <sub>INT</sub> = B1 port



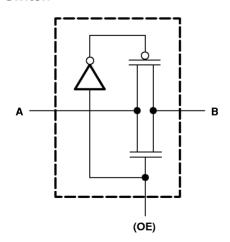
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#### logic diagram (positive logic)



### simplified schematic, each FET switch





PRODUCT PREVIEW

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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>		–0.5 V to 4.6 V
Input voltage range, V <sub>I</sub> (see Note 1)		–0.5 V to 4.6 V
Continuous channel current		128 mA
Input clamp current, $I_{IK}$ ( $V_I < 0$ )		–50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2):	: DGG package	81°C/W
	DGV package	86°C/W
	DL package	74°C/W
Storage temperature range, T <sub>sto</sub>		–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions (see Note 3)

			MIN	MAX	UNIT
Vcc	V <sub>CC</sub> Supply voltage		2.3	3.6	V
	V <sub>CC</sub> = 2.3 V to 2.7 V		1.7		V
VIH	High-level control input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		V
	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$			0.7	V
VIL	Low-level control input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8	V
TA	Operating free-air temperature		<b>-4</b> 0	85	°C

NOTE 3: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PA	RAMETER		TEST CONDITIONS		MIN	TYP‡	MAX	UNIT
V <sub>IK</sub>		V <sub>CC</sub> = 3 V,	I <sub>I</sub> = −18 mA				-1.2	V
lį		$V_{CC} = 3.6 \text{ V},$	$V_{CC} = 3.6 \text{ V},$ $V_I = V_{CC} \text{ or GND}$				±1	μΑ
loff		$V_{CC} = 0$ ,	$V_{  }$ or $V_{  } = 0$ to 3.6	S V			10	μΑ
Icc		$V_{CC} = 3.6 \text{ V},$	I <sub>O</sub> = 0,	V <sub>I</sub> = V <sub>CC</sub> or GND			10	μΑ
ΔICC§	Control input	$V_{CC} = 3.6 \text{ V},$	One input at 3 V,	Other inputs at V <sub>CC</sub> or GND			300	μΑ
Ci	Control input	V <sub>I</sub> = 3 V or 0						pF
C <sub>io(OFF</sub>	-)	V <sub>O</sub> = 3 V or 0						pF
R <sub>INT</sub>	B1 or B2	$V_{CC} = 3.3 \text{ V},$	$V_{CC} = 3.3 \text{ V}, \qquad I_{O} = 4 \text{ mA}$			500		Ω
		V 00V	V <sub>I</sub> = 0	I <sub>I</sub> = 64 mA				
		$V_{CC} = 2.3 \text{ V},$ TYP at $V_{CC} = 2.5 \text{ V}$	V  = 0	I <sub>I</sub> = 24 mA				
			$V_{ } = 1.7 V$ ,	I <sub>I</sub> = 15 mA				Ω
ron¶			\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	I <sub>I</sub> = 64 mA				22
		V <sub>CC</sub> = 3 V	V <sub>I</sub> = 0	I <sub>I</sub> = 24 mA				
			V <sub>I</sub> = 2.4 V,	l <sub>I</sub> = 15 mA				

<sup>‡</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$  (unless otherwise noted),  $T_A = 25^{\circ}\text{C}$ .



NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51.

<sup>§</sup> This is the increase in supply current for each input that is at the specified voltage level rather than V<sub>CC</sub> or GND.

Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

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## switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> =	V <sub>CC</sub> = 2.5 V ± 0.2 V		3.3 V 3 V	UNIT
	(INFOT)	(001701)	MIN	MAX	MIN	MAX	
<sub>tpd</sub> †	A or B	B or A					ns
t <sub>en</sub>	S	A or B					ns
<sup>t</sup> dis	S	A or B					ns

<sup>†</sup> The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

### switching characteristics, $T_A = 0$ °C to 70°C (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
	(INFOT)		MIN	MAX	MIN	MAX	
<sub>tpd</sub> †	A or B	B or A					ns
<sup>t</sup> en	S	A or B					ns
<sup>t</sup> dis	S	A or B					ns

<sup>†</sup> The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

### switching characteristics, $T_A = 0$ °C to 70°C (unless otherwise noted) (see Figures 1 and 2)

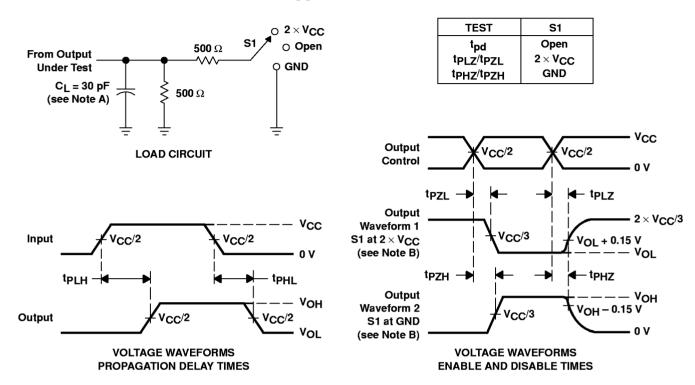
PARAMETER	DESCRIPTION		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 3.3 V ± 0.3 V	
		MIN	MAX	MIN	MAX	
t <sub>mbb</sub> ‡	Make-before-break time					ns

<sup>‡</sup>The make-before-break time is the time interval between make and break, during the transition from one selected port to the other.



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## PARAMETER MEASUREMENT INFORMATION $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$



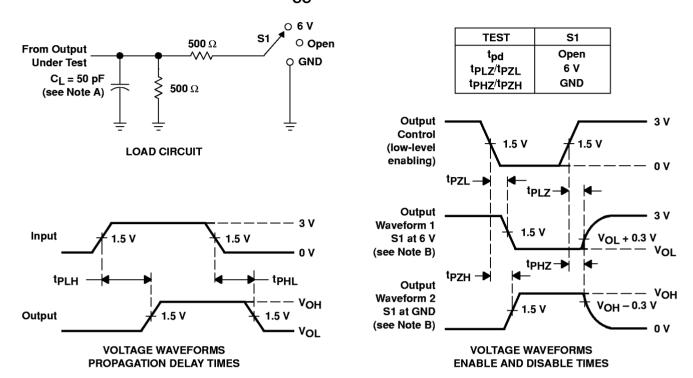
- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50 \Omega$ ,  $t_f \leq 2$  ns.
  - D. The outputs are measured one at a time with one transition per measurement.
  - E. tpLZ and tpHZ are the same as tdis.
  - F. tpzL and tpzH are the same as ten.
  - G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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# PARAMETER MEASUREMENT INFORMATION $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_{O}$  = 50  $\Omega$ ,  $t_{f} \leq$  2.5 ns,  $t_{f} \leq$  2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLZ and tpHZ are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpl H and tpHI are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms



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